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*Podilchuk, C.I.; Wenjun Zeng;*

Selected Areas in Communications, IEEE Journal on , Volume: 16 , Issue: 4 , 1998

Pages:525 - 539

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**2 Image protection via watermarking on perceptually significant wavelet coefficients**

*Houng-Jyh Wang; Kuo, C.-C.J.;*

Multimedia Signal Processing, 1998 IEEE Second Workshop on , 7-9 Dec. 1998  
 Pages:279 - 284

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**3 The effect of matching watermark and compression transforms in compressed color images**

*Wolfgang, R.B.; Podilchuk, C.I.; Delp, E.J.;*

Image Processing, 1998. ICIP 98. Proceedings. 1998 International Conference on , Volume: 1 , 4-7 Oct. 1998

Pages:440 - 444 vol.1

[\[Abstract\]](#)   [\[PDF Full-Text \(644 KB\)\]](#)   IEEE CNF

**4 A multiresolution watermark for digital images**

*Xiang-Gen Xia; Boncelet, C.G.; Arce, G.R.;*

Image Processing, 1997. Proceedings., International Conference on , Volume 1 , 26-29 Oct. 1997

Pages:548 - 551 vol.1

[\[Abstract\]](#)   [\[PDF Full-Text \(736 KB\)\]](#)   **IEEE CNF**

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